

Notice of References Cited	Application/Control No. 10/568,022		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner /Susan W. Berman/		Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2008/0118658	05-2008	Kato et al.	427/508
*	C	US-4,623,594	11-1986	Keough, Allen H.	428/500
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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